
**Microbeam analysis — Electron
probe microanalysis — Quantitative
analysis of Mn dendritic segregation in
continuously cast steel product**

*Analyse par microfaisceaux — Analyse par microsonde de Castaing
— Analyse quantitative de la ségrégation dendritique du manganèse
dans un produit en acier coulé en continu*

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This document was prepared by Technical Committee ISO/TC 202, *Microbeam analysis*, Subcommittee SC 2, *Electron probe microanalysis*.

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